

<IGBT Modules>

### CM400DY-40TA

HIGH POWER SWITCHING USE INSULATED TYPE



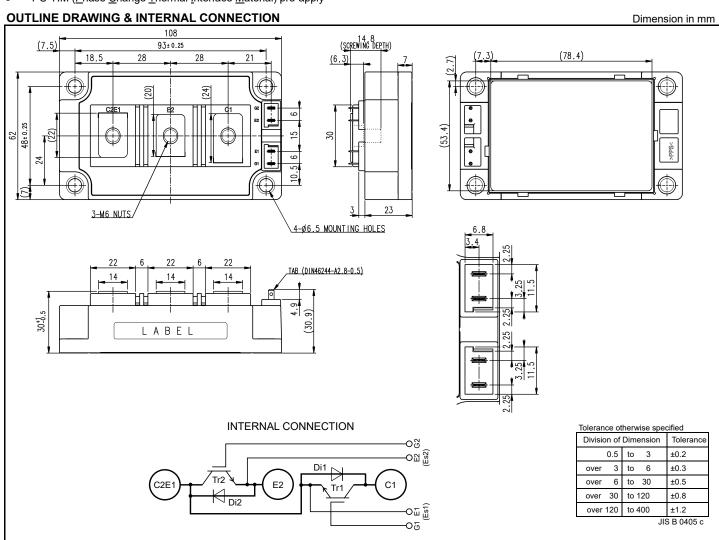
- Dual switch (Half-bridge)
- Flat base type
- Nickel-plating tab terminals
- RoHS Directive compliant
- UL Recognition under 1557, File No.E323585

#### **APPLICATION**

Medium voltage drive, etc.

#### **OPTION**

- V<sub>CEsat</sub> selection for parallel connection
- PC-TIM (<u>Phase Change Thermal Interface Material</u>) pre-apply



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MAXIMUM RATINGS (Tvj=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Rating	Unit	
V <sub>CES</sub>	Collector-emitter voltage	G-E short-circuited	2000	V	
V <sub>GES</sub>	Gate-emitter voltage	C-E short-circuited	± 20	V	
Ic	Callantan annount	DC, T <sub>C</sub> = 139 °C (Note2, 4)	400	_	
I <sub>CRM</sub>	Collector current	Pulse, Repetitive (Note3)	800	A	
P <sub>tot</sub>	Total power dissipation	pation T <sub>C</sub> = 25 °C (Note2, 4)		W	
I <sub>E</sub> (Note1)	F	DC (Note2)	400		
I <sub>ERM</sub> (Note1)	Emitter current	Pulse, Repetitive (Note3)	800	A	
V <sub>isol</sub>	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V	
T <sub>vjmax</sub>	Maximum junction temperature	Instantaneous event (overload) (Note8)	175	°C	
T <sub>Cmax</sub>	Maximum case temperature	(Note4, 8)	150	°C	
T <sub>vjop</sub>	Operating junction temperature	Continuous operation (Note8)	-40 ~ +150	°C	
T <sub>stg</sub>	Storage temperature	-	-40 ~ +150	°C	

Cumbal	Item	Item Conditions			Limits		
Symbol	item	Conditions	Conditions		Тур.	Max.	Unit
I <sub>CES</sub>	Collector-emitter cut-off current	V <sub>CE</sub> = V <sub>CES</sub> , G-E short-circuited		-	-	1	mA
I <sub>GES</sub>	Gate-emitter leakage current	V <sub>GE</sub> = V <sub>GES</sub> , C-E short-circuited		-	-	0.5	μΑ
$V_{GE(th)}$	Gate-emitter threshold voltage	$I_C = 40 \text{ mA}, V_{CE} = 10 \text{ V}$		5.5	6.0	6.6	V
V <sub>CEsat</sub>		$I_C = 400 \text{ A}, V_{GE} = 15 \text{ V},$	T <sub>vj</sub> = 25 °C	-	1.80	2.15	
		Refer to the figure of test circuit	T <sub>vj</sub> = 125 °C	-	2.15	-	V
(Terminal)	Callantan amittan antonetian walte na	(Note5)	T <sub>vj</sub> = 150 °C	-	2.20	-	
\/	Collector-emitter saturation voltage	I <sub>C</sub> = 400 A, V <sub>GE</sub> = 15 V,	T <sub>vj</sub> = 25 °C	-	1.75	2.00	
V <sub>CEsat</sub>		(Note5)	T <sub>vj</sub> = 125 °C	-	2.10	-	V
(Chip)			T <sub>vj</sub> = 150 °C	-	2.15	-	
Cies	Input capacitance			-	-	110	
Coes	Output capacitance	V <sub>CE</sub> = 10 V, G-E short-circuited	V <sub>CE</sub> = 10 V, G-E short-circuited		-	1.9	nF
Cres	Reverse transfer capacitance			-	-	0.8	
Q <sub>G</sub>	Gate charge	V <sub>CC</sub> = 1300 V, I <sub>C</sub> = 400 A, V <sub>GE</sub> = 15 V		-	3.2	-	μC
t <sub>d(on)</sub>	Turn-on delay time	$V_{CC}$ = 1300 V, $I_C$ = 400 A, $V_{GE}$ = ±15 V, $R_G$ = 0 $\Omega$ , Inductive load		-	-	800	ns
tr	Rise time			-	-	150	
t <sub>d(off)</sub>	Turn-off delay time			-	-	900	
t <sub>f</sub>	Fall time			-	-	2300	
V (Note1)		I <sub>E</sub> = 400 A, G-E short-circuited,	T <sub>vj</sub> = 25 °C	-	2.10	3.05	
V <sub>EC</sub> (Note1)		Refer to the figure of test circuit	T <sub>vj</sub> = 125 °C	-	2.40	-	V
(Terminal)		(Note5)	T <sub>vj</sub> = 150 °C	-	2.40	-	
(Note1)	Emitter-collector voltage	I <sub>E</sub> = 400 A, G-E short-circuited,	T <sub>vj</sub> = 25 °C	-	2.00	2.75	
V <sub>EC</sub> (Note1)		(Note5)	T <sub>vj</sub> = 125 °C	-	2.30	-	V
(Chip)			T <sub>vj</sub> = 150 °C	-	2.30	-	
t <sub>rr</sub> (Note1)	Reverse recovery time	V <sub>CC</sub> = 1300 V, I <sub>E</sub> = 400 A, V <sub>GE</sub> = ±15 V,	,	-	-	1000	ns
Q <sub>rr</sub> (Note1)	Reverse recovery charge	$R_G = 0 \Omega$ , Inductive load		-	105	-	μC
E <sub>on</sub>	Turn-on switching energy per pulse	V <sub>CC</sub> = 1300 V, I <sub>C</sub> = I <sub>E</sub> = 400 A,		-	215	-	
E <sub>off</sub>	Turn-off switching energy per pulse	$V_{GE} = \pm 15 \text{ V}, R_G = 0 \Omega, T_{vj} = 150 \text{ °C},$		-	340	-	mJ
E <sub>rr</sub> (Note1)	Reverse recovery energy per pulse	Inductive load		-	145	-	
R <sub>CC'+EE'</sub>	Internal lead resistance	Main terminals-chip, per switch, T <sub>C</sub> = 25 °C (Note4)		-	0.30	-	mΩ
r <sub>g</sub>	Internal gate resistance	Per switch		-	1.9	_	Ω

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HIGH POWER SWITCHING USE

**INSULATED TYPE** 

#### THERMAL RESISTANCE CHARACTERISTICS

Symbol	Itama	Item Conditions		Limits			Unit
	item			Min.	Тур.	Max.	Unit
$R_{th(j-c)Q}$	Thermal resistance	Junction to case, per Inverter IGBT (Note4)		-	-	35	K/kW
$R_{th(j-c)D}$	Thermal resistance	Junction to case, per Inverter FWD (Note4)		1	-	64	IVINVV
R <sub>th(c-s)</sub>	Contact thermal resistance	Case to heat sink, per 1 module.	Thermal grease applied (Note4, 6, 8)	-	13.3	-	K/kW

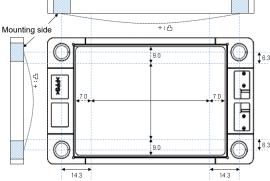
#### **MECHANICAL CHARACTERISTICS**

Symbol	Item	Conditions		Limits			Unit	
	item	Condi	uons	Min.	Тур. Мах.	Offic		
Mt	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N·m	
Ms		Mounting to heat sink	M 6 screw	3.5	4.0	4.5	N·m	
٦	Creepage distance	Terminal to terminal		17.3	-	-	ma ma	
ds		Terminal to base plate		25.3	-	-	mm	
da	Clearance	Terminal to terminal		12.6	-	-	- mm	
		Terminal to base plate		21.8	-	-		
ec	Flatness of base plate	On the centerline X, Y (Note7)		0	-	+200	μm	
m	mass	_		-	260	-	g	

<sup>\*:</sup> This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU)2015/863.

Note 1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

- 2. Junction temperature  $(T_{\nu j})$  should not increase beyond  $T_{\nu j \, m \, a \, x}$  rating.
- 3. Pulse width and repetition rate should be such that the device junction temperature (Tvj) dose not exceed Tvjmax rating.
- 4. Case temperature (T<sub>C</sub>) and heat sink temperature (T<sub>S</sub>) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
- 5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.
- 6. Typical value by using thermally conductive grease of  $\lambda$ =3.0 W/(m·K)/D<sub>(C-S)</sub>=50  $\mu$ m.
- 7. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



8. Long term performance related to thermal conductive grease (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under user's specific application conditions. Each temperature condition (T<sub>vj max</sub>, T<sub>vj op</sub>, T<sub>C max</sub>) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

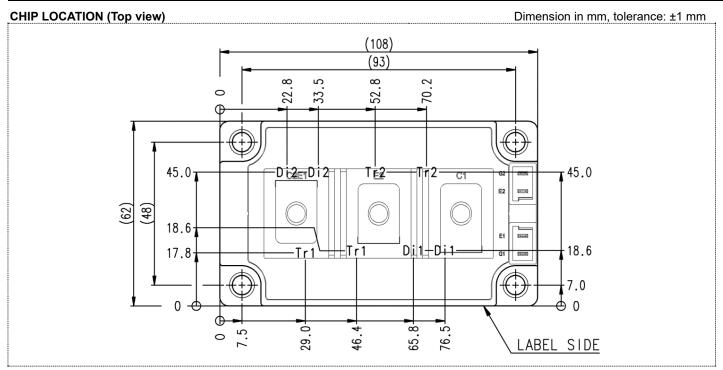
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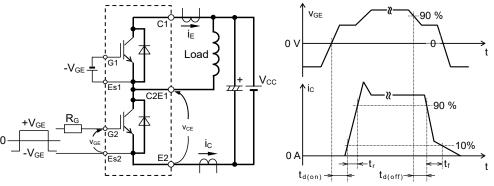
#### **RECOMMENDED OPERATING CONDITIONS**

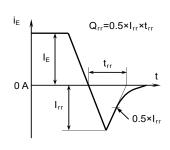
Cumbal	Itom	Conditions	Limits		Unit	
Symbol	Item	Conditions	Min.	Тур.	Max.	Offic
Vcc	(DC) Supply voltage	Applied across C1-E2 terminals	1	1300	1500	V
$V_{GEon}$	Gate-emitter drive voltage	Applied across G1-Es1/G2-Es2 terminals	13.5	15.0	16.5	V
R <sub>G</sub>	External gate resistance	Per switch	0	-	10	Ω



Tr1/Tr2: IGBT, Di1/Di2: FWD

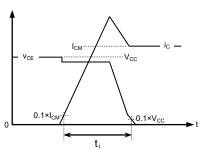
#### **TEST CIRCUIT AND WAVEFORMS**

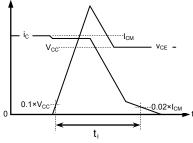


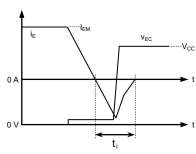


Switching characteristics test circuit and waveforms

t<sub>rr</sub>, Q<sub>rr</sub> characteristics test waveform





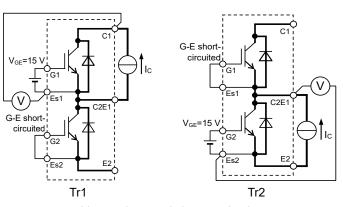


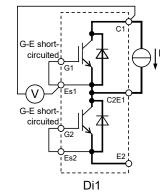
IGBT Turn-on switching energy

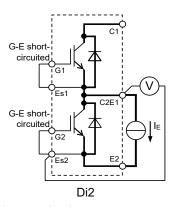
IGBT Turn-off switching energy

FWD Reverse recovery energy

Switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)





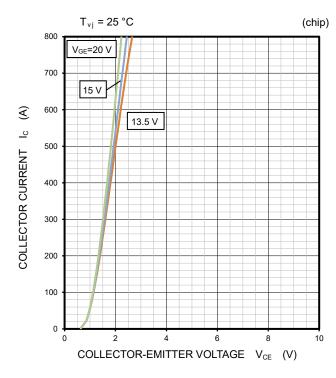


V<sub>CEsat</sub> characteristics test circuit

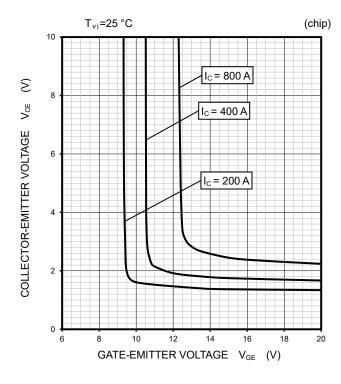
V<sub>EC</sub> characteristics test circuit

#### **INVERTER PART**

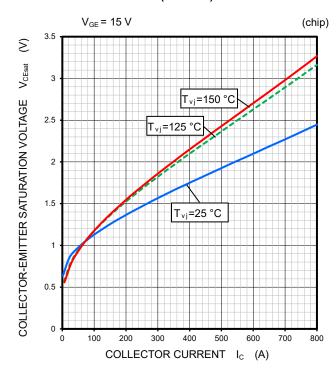
### OUTPUT CHARACTERISTICS (TYPICAL)



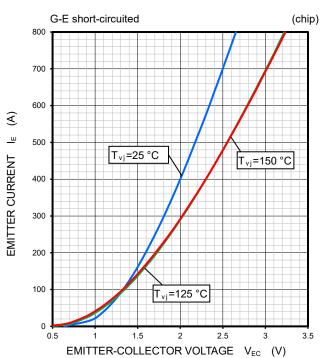
## COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS (TYPICAL)



#### COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)

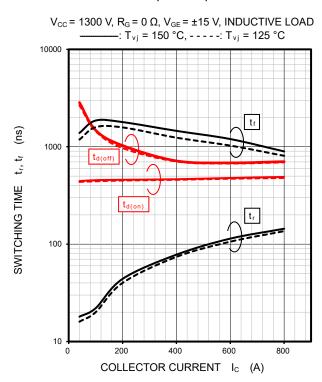


#### FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)

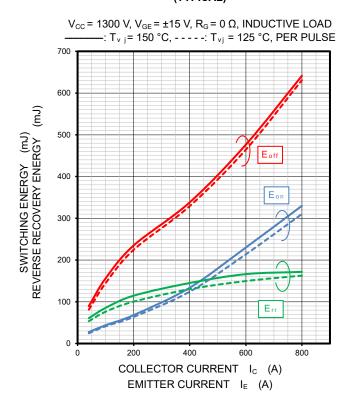


#### **INVERTER PART (continued)**

#### HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

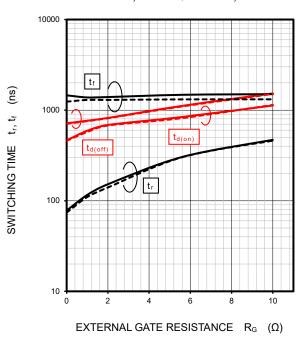


#### HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



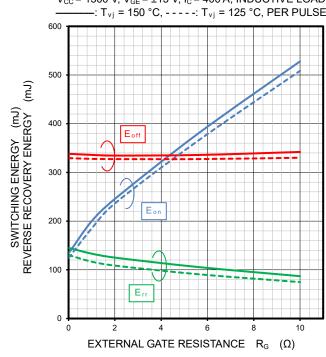
#### HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

 $V_{CC}$  = 1300 V,  $I_C$  = 400 A,  $V_{GE}$  = ±15 V, INDUCTIVE LOAD -: T<sub>vj</sub> = 150 °C, - - - -: T<sub>vj</sub> = 125 °C



#### HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

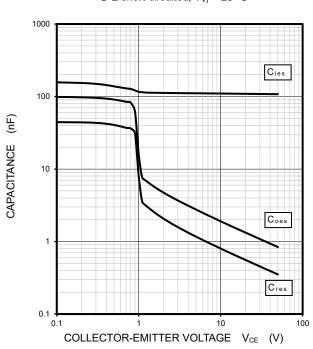
 $V_{CC}$  = 1300 V,  $V_{GE}$  = ±15 V,  $I_{C}$  = 400 A, INDUCTIVE LOAD  $T_{vj} = 150 \,^{\circ}\text{C}, ----: T_{vj} = 125 \,^{\circ}\text{C}, PER PULSE$ 



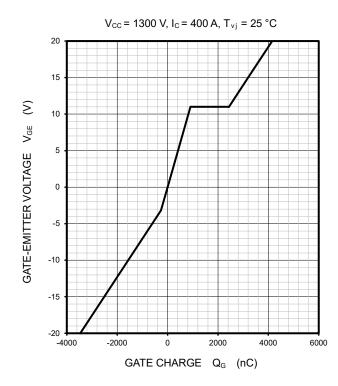
#### **INVERTER PART (continued)**

# CAPACITANCE CHARACTERISTICS (TYPICAL)



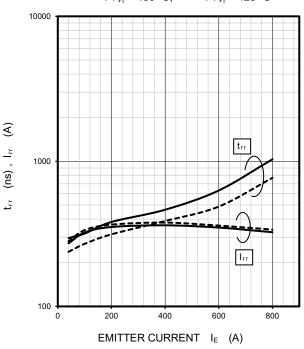


# GATE CHARGE CHARACTERISTICS (TYPICAL)



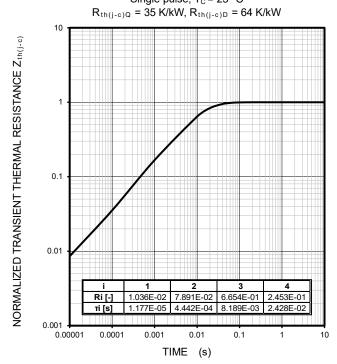
# FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

 $V_{CC} = 1300 \text{ V}, R_G = 0 \Omega, V_{GE} = \pm 15 \text{ V}, INDUCTIVE LOAD}$ -----:  $T_{vj} = 150 \,^{\circ}\text{C}, ----: T_{vj} = 125 \,^{\circ}\text{C}$ 



## TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)

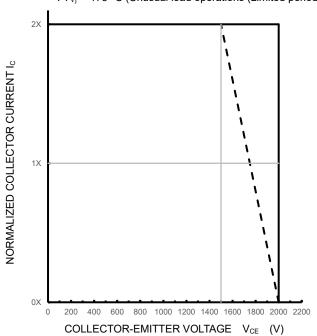
Single pulse, T<sub>C</sub>= 25 °C



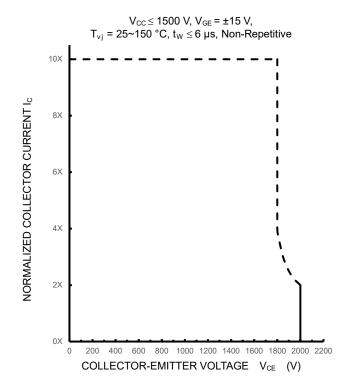
#### **INVERTER PART (continued)**

# TURN-OFF SWITCHING SAFE OPERATIONG AREA (REVERSE BIAS SAFE OPERATING AREA) (MAXIMUM)

 $V_{CC} \le 1500$  V,  $V_{GE} = \pm 15$  V,  $R_{G(off)} = 0 \sim 10$   $\Omega$ , .....:  $T_{vj} = 25 \sim 150$  °C (Normal load operations (Continuous) ....:  $T_{vj} = 175$  °C (Unusual load operations (Limited period)



# SHORT-CIRCUIT SAFE OPERATING AREA (MAXIMUM)



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